

VQ1006 SERIES

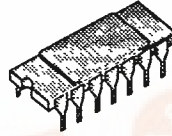


N-Channel Enhancement-Mode MOS Transistor Arrays

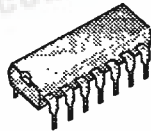
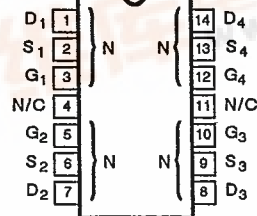
T-43-25

PRODUCT SUMMARY

PART NUMBER	$V_{(BR)DSS}$ (V)	$r_{DS(ON)}$ (Ω)	I_D (A)	PACKAGE
VQ1006J	90	4.5	0.40	Plastic
VQ1006P	90	4.5	0.40	Side Braze

14-PIN DIP
SIDE BRAZE

14-PIN PLASTIC

TOP VIEW
Dual-In-Line Package

Performance Curves: VNDQ09 (See Section 7)

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	VQ1006J	VQ1006P	UNITS
Drain-Source Voltage	V_{DS}	90	90	V
Gate-Source Voltage	V_{GS}	± 30	± 20	
Continuous Drain Current	I_D	$T_A = 25^\circ\text{C}$	0.40	A
		$T_A = 100^\circ\text{C}$	0.23	
Pulsed Drain Current ¹	I_{DM}	± 2	± 2	
Power Dissipation – Single	P_D	$T_A = 25^\circ\text{C}$	1.3	W
		$T_A = 100^\circ\text{C}$	0.52	
Power Dissipation – Quad	P_D	$T_A = 25^\circ\text{C}$	2	
		$T_A = 100^\circ\text{C}$	0.8	
Operating Junction and Storage Temperature	T_J, T_{stg}	-55 to 150		$^\circ\text{C}$
Lead Temperature (1/16" from case for 10 seconds)	T_L	300		

THERMAL RESISTANCE

THERMAL RESISTANCE	SYMBOL	VQ1006J	VQ1006P	UNITS
Junction-to-Ambient – Single	R_{thJA}	96.2	96.2	$^\circ\text{C/W}$
Junction-to-Ambient – Quad		62.5	62.5	

¹Pulse width limited by maximum junction temperature.



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ELECTRICAL CHARACTERISTICS ¹			LIMITS			
PARAMETER	SYMBOL	TEST CONDITIONS	VQ1006			UNIT
			TYP ²	MIN	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0 \text{ V}, I_D = 10 \mu\text{A}$	120	90		V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$	1.6	0.8	2.5	V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}$ $V_{GS} = \pm 15 \text{ V}$ $T_J = 125^\circ\text{C}$	± 1		± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 90 \text{ V}$ $V_{GS} = 0 \text{ V}$ $V_{DS} = 72 \text{ V}, T_J = 125^\circ\text{C}$	0.03		1	μA
On-State Drain Current ³	$I_{D(ON)}$	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}$	1.8	1.5		A
Drain-Source On-Resistance ³	$r_{DS(ON)}$	$V_{GS} = 5 \text{ V}, I_D = 0.3 \text{ A}$	4.7		5	Ω
		$V_{GS} = 10 \text{ V}$ $I_D = 1 \text{ A}$ $T_J = 125^\circ\text{C}$	4.1		4.5	
			7.7		8.6	
Forward Transconductance ³	g_{FS}	$V_{DS} = 10 \text{ V}, I_D = 0.5 \text{ A}$	350	170		mS
Common Source Output Conductance ³	g_{OS}	$V_{DS} = 10 \text{ V}, I_D = 0.1 \text{ A}$	225			μS
DYNAMIC						
Input Capacitance	C_{iss}	$V_{DS} = 25 \text{ V}$ $V_{GS} = 0 \text{ V}$ $f = 1 \text{ MHz}$	35		60	pF
Output Capacitance	C_{oss}		15		50	
Reverse Transfer Capacitance	C_{rss}		2		10	
SWITCHING						
Turn-On Time	t_{ON}	$V_{DD} = 25 \text{ V}, R_L = 23 \Omega$ $I_D = 1 \text{ A}, V_{GEN} = 10 \text{ V}$ $R_G = 25 \Omega$ (Switching time is essentially independent of operating temperature)	6		10	ns
Turn-Off Time	t_{OFF}		8		10	

- NOTES: 1. $T_A = 25^\circ\text{C}$ unless otherwise noted.
 2. For design aid only, not subject to production testing.
 3. Pulse test; $PW = 300 \mu\text{s}$, duty cycle $\leq 2\%$.
 4. This parameter has been revised from previous data sheet.